MOSFET – Power, Single, N-Channel 60 V, 61 A, 12 mΩ

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5844NLWF Wettable Flanks Product
- NVMFS Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	60	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain Cur-		T _{mb} = 25°C	I _D	61	Α
rent R $_{\Psi J-mb}$ (Notes 1, 2, 3, 4)	Steady State	T _{mb} = 100°C		43	
Power Dissipation	State	T _{mb} = 25°C	P_{D}	107	W
R _{ΨJ-mb} (Notes 1, 2, 3)		T _{mb} = 100°C		54	
Continuous Drain Current R _{0.IA} (Notes 1, 3,		T _A = 25°C	I _D	11.2	Α
4)	Steady	T _A = 100°C		8.0	
Power Dissipation	State	T _A = 25°C	P_{D}	3.7	W
R _{θJA} (Notes 1 & 3)		T _A = 100°C		1.8	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	247	Α
Current Limited by Package T _A = 25°C (Note 4)		I _{DmaxPkg}	80	Α	
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C
Source Current (Body Diode)			I _S	60	Α
Single Pulse Drain-to-Source Avalanche Energy (T_J = 25°C, V_{DD} = 50 V, V_{GS} = 10 V, $I_{L(pk)}$ = 31 A, L = 0.1 mH, R_G = 25 Ω)			E _{AS}	48	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T_L	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	Reia	41	

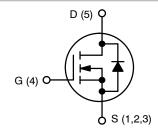
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.



ON Semiconductor®

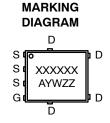
http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
60 V	12 mΩ @ 10 V	61 A
00 V	16 mΩ @ 4.5 V	O A



N-CHANNEL MOSFET





A = Assembly Location

Y = Year

W = Work Week

ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

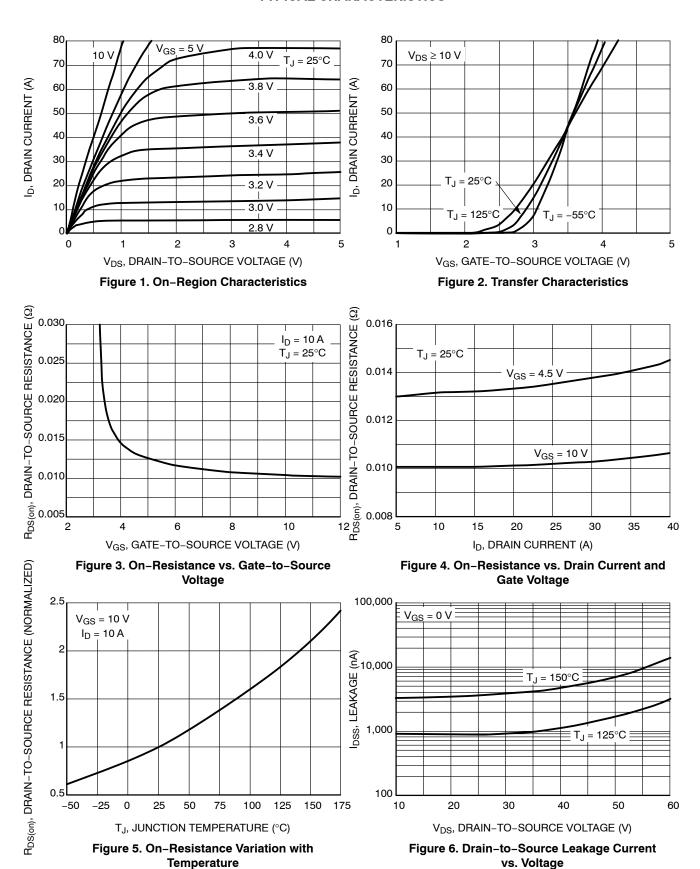
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		•			•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				57		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25 °C			1	
		V _{DS} = 60 V	T _J = 125°C			100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)					-		-
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.5		2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		10.2	12	
		V _{GS} = 4.5 V	I _D = 10 A		13	16	mΩ
Forward Transconductance	9FS	V _{DS} = 5 V, I _D	= 10 A		27		S
CHARGES, CAPACITANCES & GATE RESIS	STANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			1460		
Output Capacitance	C _{OSS}				150		pF
Reverse Transfer Capacitance	C _{RSS}				96		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V; I _D = 10 A			30		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 48 V; I _D = 10 A			15		
Threshold Gate Charge	Q _{G(TH)}				1.0		nC
Gate-to-Source Charge	Q_{GS}				4.0		
Gate-to-Drain Charge	Q_{GD}				8.0		
Plateau Voltage	V_{GP}				3.0		V
Gate Resistance	R _G				0.62		Ω
SWITCHING CHARACTERISTICS (Note 6)					-		-
Turn-On Delay Time	t _{d(ON)}				12		
Rise Time	t _r	V_{GS} = 4.5 V, V_{DS} = 48 V, I_{D} = 10 A, R_{G} = 2.5 Ω			25		
Turn-Off Delay Time	t _{d(OFF)}				20		ns
Fall Time	t _f				10		1
DRAIN-SOURCE DIODE CHARACTERISTIC	S						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.79	1.2	
		I _S = 10 A	T _J = 125°C		0.65		V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$			19		
Charge Time	ta				13		ns
Discharge Time	t _b				6.0		1
Reverse Recovery Charge	Q_{RR}				15		nC

- 5. Pulse Test: pulse width \leq 300 $\mu\text{s},$ duty cycle \leq 2%.
- 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

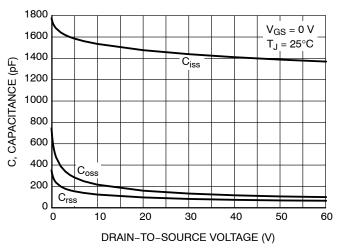


Figure 7. Capacitance Variation

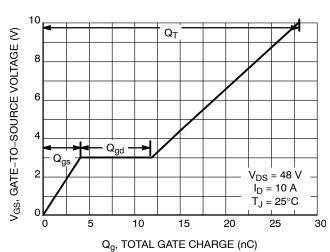


Figure 8. Gate-to-Source Voltage vs. Total Charge

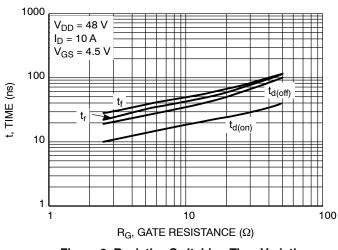


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

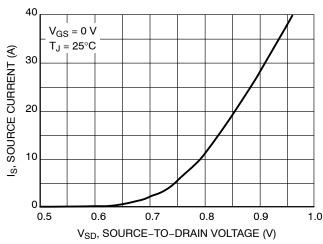


Figure 10. Diode Forward Voltage vs. Current

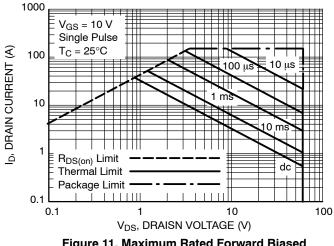


Figure 11. Maximum Rated Forward Biased Safe Operating Area

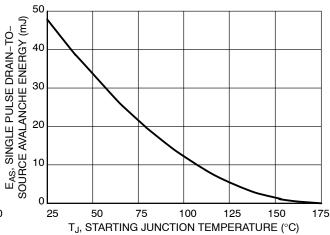


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

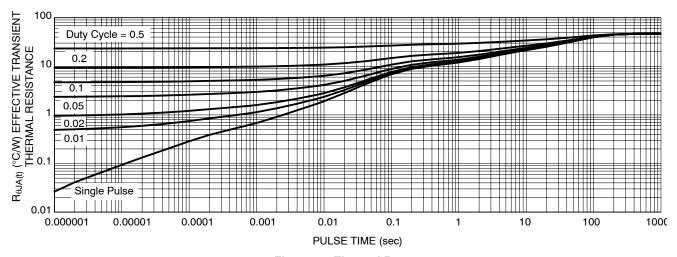


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMFS5844NLT1G	5844NL	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5844NLT1G	V5844L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5844NLWFT1G	5844LW	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5844NLT3G	V5844L	DFN5 (Pb-Free)	5000 / Tape & Reel
NVMFS5844NLWFT3G	5844LW	DFN5 (Pb-Free)	5000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



0.10

0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*



XXXXXX = Specific Device Code

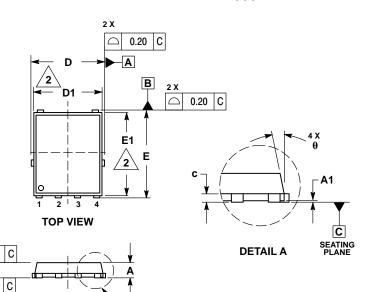
= Assembly Location Α

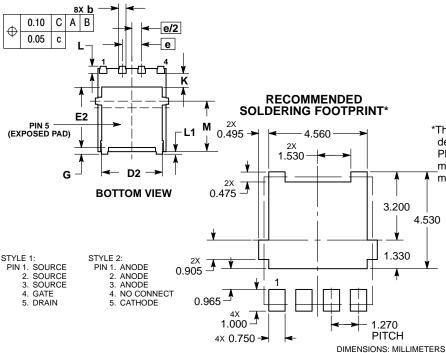
= Lot Traceability

Υ = Year W = Work Week

ZZ

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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